

Application/Control No.	Applicant(s)/Patent under Reexamination		
10/552,463	ISHII ET AL.		
Examiner	Art Unit		
L. E. Crane	1623		

SEARCHED					
Class	Subclass	Date	Examiner		
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
536	027.110	2/1/2008	LEC		
536	028.530	2/1/2008	LEC		

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5/14/2007	LEC
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